Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination LEE, JONG HYEOK	
10/769,813		
Examiner	Art Unit	
TAN X. DINH	2627	

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	ce Search Printout	2/14/2008	T.D

SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
EAST (see search history printout)	2/14/2008	T.D
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